Notice of References Cited

Application/Control No. 10/008,196	Applicant(s)/Patent Under Reexamination DE VRIES ET AL.	
Examiner	Art Unit	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,091,691	07-2000	Yoo et al.	369/112.11
	В	US-6,201,780	03-2001	Katayama, Ryuichi	369/112.19
	С	US-5,926,450	07-1999	Braat, Josephus J. M.	369/53.2
	D	US-6,016,293	01-2000	Lee et al.	369/44.25
	Е	US-5,903,536	05-1999	Lee et al.	342/357.03
	F	US-6,370,103	04-2002	Yamazaki et al.	369/112.26
	G	US-6,687,209	02-2004	Ota et al.	369/112.08
	Н	US-			
	1	US-			
	J	US-			
,	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	1
	N				 -		
	0						
	Р						
	Q				 		
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	V			
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	х			

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